Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/671,861	LEE, MICHAEL	
Examiner	Art Unit	
Alex Liew	2624	

	SEARCHED				
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INT	INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARCH		<u> </u>
	DATE	EXMR
382/141-152 limited to text search	2/26/2007	AL ·
209/517 limited to text search	2/26/2007	AL
382/141-152 limited to text search	7/3/2007	AL
209/517 limited to text search	7/3/2007	AL
382/141-152 limited to text search	10/24/2007	AL
209/517 limited to text search	10/24/2007	AL